

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/693,060	SHORT ET AL.	
Examiner	Art Unit	
Michael Y. Won	2155	

SEARCHED					
Class	Subclass	Date	Examiner		
709	225, 227, 230	12/16/2005	MW		
			:		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH N (INCLUDING SEAR)		)
	DATE	EXMR
EAST: USPAT; USPG-PUB; DERWENT; EPO; JPO	12/16/2005	MW
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